Introduction

This document describes the wafer level chip size package (WLCSP) and provides recommendation on how to use it. Only WLCSP for microcontrollers are described herein.

The competitive market of portable equipment, in particular the mobile phone market, is driven by the challenging development of highly integrated devices. To allow manufacturers of portable equipment to minimize the dimension of their devices, STMicroelectronics has developed WLCSP with reduced size, thickness and weight. The electrical performance of such components is improved by using shorter connections than in standard plastic packages such as TSSOP, SSOP or BGA.

The WLCSP family is designed to fulfill the same quality levels and same reliability performance as standard semiconductor plastic packages. As a consequence these new WLCSP can be considered as new surface mount devices which are assembled on a printed circuit board (PCB) without any special or additional process steps. In particular these packages do not require any extra underfill to increase reliability performance or to protect the device. These packages are compatible with existing pick-and-place equipment for board mounting. Only Lead-free RoHS compliant WLCSP are available in mass production. The packages offered in WLCSP are listed in Table 1.

This document addresses the following topics:

- Package description
- Device marking
- Packing specifications and labeling
- Storage and shipping recommendations
- Soldering assembly recommendations
- Package changes and package quality
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# List of WLCSP packages

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<table>
<thead>
<tr>
<th>Code</th>
<th>Leads</th>
<th>Description</th>
<th>MACRO_PACKAGE_CODE</th>
<th>MOISTURE_SENSITIVITY_CODE</th>
</tr>
</thead>
<tbody>
<tr>
<td>CR</td>
<td>64</td>
<td>WLCSP 64L R8X8 0.5 mm pitch</td>
<td>SX</td>
<td>1</td>
</tr>
<tr>
<td>A0AM</td>
<td>28</td>
<td>WLCSP 28L R4X7 pitch 0.4 mm</td>
<td>SX</td>
<td>1</td>
</tr>
<tr>
<td>A0JV</td>
<td>64</td>
<td>WLCSP 64 BALLS DIE 436 P 0.4 mm</td>
<td>SX</td>
<td>1</td>
</tr>
<tr>
<td>A0JW</td>
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<tr>
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<tr>
<td>A0R5</td>
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</tr>
<tr>
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<td>WLCSP 63L (7X9) DIE 427 P 0.4 mm</td>
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<tr>
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<td>WLCSP 72L DIE 415 PITCH 0.4 mm</td>
<td>SX</td>
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<tr>
<td>A0XJ</td>
<td>49</td>
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<tr>
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<tr>
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<tr>
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<tr>
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<td>WLCSP 100L P 0.4mm DIE 446</td>
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<td>1</td>
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<tr>
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<td>A05M</td>
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<tr>
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<td>SX</td>
<td>1</td>
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<tr>
<td>Code</td>
<td>Leads</td>
<td>Description</td>
<td>MACRO_PACKAGE_CODE</td>
<td>MOISTURE_SENSITIVITY_CODE</td>
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<tr>
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<td>-------</td>
<td>------------------------------</td>
<td>--------------------</td>
<td>---------------------------</td>
</tr>
<tr>
<td>A05Z</td>
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<td>1</td>
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<tr>
<td>A06J</td>
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<td>WLCSP 25L DIE 460 P 0.4 mm</td>
<td>SX</td>
<td>1</td>
</tr>
<tr>
<td>A04Z</td>
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<td>WLCSP 49L DIE 435 P 0.4 mm</td>
<td>SX</td>
<td>1</td>
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<tr>
<td>A076</td>
<td>32</td>
<td>WLCSP 32L DIE 768</td>
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</table>
2 Package description

2.1 Overview

ST WLCSP packages are manufactured with a wafer level process by attaching solder balls on I/Os pads of the active wafer side, thus allowing bumped dice to be produced. The I/O contacts can be either configured as a matrix or located in the periphery. A redistribution layer is used.

Lead-free balls are manufactured using SAC (SnAgCu) alloy with a near-eutectic melting point ranging 217 to 221 °C. This material makes the package compatible with standard reflow processes.

The ball diameter allows to use pick-and-place process compatible with existing equipment, in particular with equipment used for ball grid array (BGA) packages. It also makes it compatible with the PCB design rules used for standard ICs.

The devices available in WLCSP are delivered in tape and reel packing with the bumps turned down (placed on the bottom of the carrier tape cavity). The other face of the device is flat and allows picking it as for standard SMD packages.

Caution: WLCSP must be handled with care as active silicon substrate is not protected against aggressive mechanical actions. Vacuum plastic pick-up tools are recommended for device handling.

WLCSP Devices are 100 % electrically tested after assembly.

The device references are marked on the top flat side of the device (see Figure 1).

Figure 1. WLCSP top and bump views
2.2 **Mechanical description**

An example of WLCSP outline and mechanical dimensions is given in *Figure 2* and *Table 2*. Die size and ball count are adapted to the connection requirements. Refer to device datasheet for package mechanical data and outline.

The WLCSP tolerances on ball diameter and ball height are very low. This constant ball shape insures a good coplanarity between balls. Optical measurements performed through vertical focuses show a ball-plus-die coplanarity well below 50 μm.

![Figure 2](image.png)

**Figure 2. Matrix 8 x 8 bump array WLCSP**

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Typical (mm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>0.585</td>
</tr>
<tr>
<td>A2</td>
<td>0.230</td>
</tr>
<tr>
<td>C</td>
<td>3.500</td>
</tr>
<tr>
<td>D</td>
<td>0.320</td>
</tr>
<tr>
<td>E</td>
<td>3.500</td>
</tr>
<tr>
<td>e1</td>
<td>0.500</td>
</tr>
<tr>
<td>d1</td>
<td>0.483</td>
</tr>
<tr>
<td>d2</td>
<td>0.448</td>
</tr>
</tbody>
</table>

*Table 2. Matrix 8 x 8 bump dimension WLCSP*

Typical device marking for the flat backside of the die is shown on *Figure 3*. WLCSP ball 1 is identified by the A1 pin marked on the flat backside of the die so that the orientation of the component can be easily determined before and after assembly. This dot is designed so that it can be detected by standard vision systems.
2.3 Device marking

The standard top-side laser marking contains:

- Pin 1 identification
- ST logo
- Marking areas composed of:
  - Commercial product name
  - Traceability code
  - Wafer fab code
  - Testing and finishing production location codes
  - Country where the product was assembled

Figure 3. WLCSP device marking
3 Packing specifications and labelling description

WLCSP devices are delivered in tape and reel to be fully compatible with standard high volume SMD components. All tape and reel characteristics are compliant with EIA-481-C and IEC 60286-3 standards and EIA 763 (783).

3.1 Carrier tape

The WLCSP are placed in carrier tapes with their ball side facing the bottom of the cavity so that the devices can be picked up by their flat side. No flipping of the package is required for mounting on the PCB. The devices are positioned in the carrier tape with pin A1 on the sprocket hole side.

An example of carrier tape mechanical dimensions is shown in Figure 4. The standard tape width is 8 mm for die size smaller than 3 mm (dimension B0).

Note: 12 mm carrier tape width may be used for larger die size to be in line with EIA standards.

The cavities in the carrier tape have been designed to avoid damaging the components. No hole is present in the cavity to avoid any impact or any external contamination of the solder bumps. Refer to Table 3 for the cavity dimension according to the die size.

The embossed carrier tape is in a black conductive material (surface resistivity within 10E4 and 10E8 Ω/sq). Using this material prevents the component from being damaged by electrostatic discharge and ensures the total discharge of the component prior to the placement on the PCB. Conductivity is guaranteed to be constant and is not affected by shelf life or humidity. The material does not break when bent and does not have any powder or flake residue that rubs off.
3.2 Cover tape

The carrier tape is sealed with a transparent antistatic (surface resistivity ranging from $10^5\ \Omega/\text{sq}$ to $10^12\ \Omega/\text{sq}$) polyester film cover tape using a heat activated adhesive. The cover tape tensile strength is higher than 10 N.

The peeling force of the cover tape ranging from 0.1 N to 0.7 N in accordance with the testing method EIA-481-C and IEC 60286-3. Cover tape is peeled back in the direction opposite to the carrier tape travel. The angle between the cover tape and the carrier tape is between 165 and 180 °, and the test is performed at a speed of 120 ± 10 % mm/min.

3.3 Reels

The sealed carrier tape containing the WLCSP is reeled on 7 inch or 13 inch reels (see Figure 5 and Table 4 for reel mechanical dimensions). These reels are compliant with EIA-481-C standard. In particular, they are made of an antistatic polystyrene material. The reel color may vary depending on supplier.

Dice quantity per reel is 3000 (with typical package thickness equal to 650 µm). In compliance with the IEC 60286-3, each reel contains a maximum of 0.1 % empty cavities. Two successive empty cavities are not allowed. A reel may contain devices coming from 2 different wafer lots.

The reels have a minimum leader of 600 mm and a minimum trailer of 160 mm (in compliance with EIA-481-C and IEC 60286-3 standards). The leader makes up a portion of carrier tape with empty cavities and sealed by cover tape at the beginning of the reel (external side). It is affixed to the last turn of the carrier tape by using adhesive tape. The trailer is located at the end of the reel and consists of empty sealed cavities.

<table>
<thead>
<tr>
<th>Die dimensions</th>
<th>Tape cavity dimension (A0 and B0)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Die with both sides ≤ 1.5 mm</td>
<td>Die side size + 70 µm</td>
</tr>
<tr>
<td>Die with one side &gt; 1.5 mm</td>
<td>Cavity dimensions must ensure that component rotation cannot exceed 5 ° max.</td>
</tr>
</tbody>
</table>
Figure 5. 7 and 13 inch reel schematics

Table 4. 7 and 13 inch reel dimensions

| Reel | W1 (mm)
<table>
<thead>
<tr>
<th></th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>W2 (mm)</td>
</tr>
<tr>
<td>7&quot;</td>
<td></td>
</tr>
<tr>
<td></td>
<td>12.8 (typ)</td>
</tr>
<tr>
<td></td>
<td>16.8 (typ)</td>
</tr>
<tr>
<td></td>
<td>24.8 (typ)</td>
</tr>
<tr>
<td></td>
<td>32.8 (typ)</td>
</tr>
<tr>
<td></td>
<td>44.8 (typ)</td>
</tr>
<tr>
<td>13&quot;</td>
<td></td>
</tr>
<tr>
<td></td>
<td>8.4 (typ)</td>
</tr>
<tr>
<td></td>
<td>12.4 (typ)</td>
</tr>
<tr>
<td></td>
<td>16.4 (typ)</td>
</tr>
<tr>
<td></td>
<td>24.4 (typ)</td>
</tr>
<tr>
<td></td>
<td>32.4 (typ)</td>
</tr>
<tr>
<td></td>
<td>44.4 (typ)</td>
</tr>
</tbody>
</table>

1. +0.6 mm, -0.4 mm.
2. Measured at the hub.
3. +0.5 mm, -0.2 mm.
4. ±0.25 mm.
5. -0.5 mm, -0.2 mm.
3.4 Final packing

Each reel is heat-sealed under inert atmosphere in a transparent recyclable antistatic polyethylene bag (minimum of 4 mils material thickness). A full description of the packing process is shown in below:

Figure 6. WLCSP reels are completed with Pink EPE protector

Each reel is packed under inert N2 atmosphere in a sealed bag with Desiccant & HIC (Humidity Indicator). (No vacuum sealing). The MBB bag is then wrapped by one layer of bubble sheet and then placed in a cardboard box.

Figure 7. Reel in MBB (no vacuum sealing)
These cardboard boxes are then vertically packed in outer boxes.
3.5 Labelling

To trace each production lot and shipment lot, the 7 inch reels and the cardboard box are identified by labels that mention the device part number, the shipped quantity and traceability information.

The trace code printed on the labels ensures backward traceability from the lot received by the customer to each step of the process. It includes in/ out dates, as well as quantities during diffusion, assembly, test phase, and in the final storage. Likewise, forward traceability is able to trace a lot history from the wafer fab to the customer location.

3.6 Storage and shipping recommendations

WLCSP reels are packed under inert N2 atmosphere in a sealed bag. For shipment and handling, reels are packed in a cardboard box.

ST consequently recommends the following shipping and storage conditions:

- Relative humidity between 15 and 70 %
- Temperature ranging from -55 to +150 °C.
- Components in tape and reel must be protected from exposure to direct sunlight.

Note: Moisture sensitivity level (MSL as per JEDEC J-STD-020) is considered to be 1 for all MCD WLCSPs.
4 Soldering assembly recommendations

4.1 PCB design recommendations

For optimum electrical performance and highly reliable solder joints, ST recommends to follow the PCB design guidelines listed in Table 5 and Table 6.

PCB pad positioning and size must properly designed to optimize the natural self-centering effect of the WLCSP on the PCB.

**Note:** A too thick gold layer finishing on the PCB pad is not recommended since it results in low joint reliability.

<table>
<thead>
<tr>
<th>PCB design list</th>
<th>Recommendation</th>
</tr>
</thead>
<tbody>
<tr>
<td>PCB pad design</td>
<td>Non-solder mask defined micro via underbump allowed</td>
</tr>
<tr>
<td>PCB pad size</td>
<td>Ø = 300 μm max (circular) - 250 μm recommended</td>
</tr>
<tr>
<td>Solder mask opening</td>
<td>Ø = 340 μm min (for 300 μm diameter pad)</td>
</tr>
</tbody>
</table>

**Table 5. PCB design recommendation for 0.5 mm ball pitch packages**

<table>
<thead>
<tr>
<th>PCB design list</th>
<th>Recommendation</th>
</tr>
</thead>
<tbody>
<tr>
<td>PCB pad design</td>
<td>Non-solder mask defined micro via underbump allowed</td>
</tr>
<tr>
<td>PCB pad size</td>
<td>Ø = 260 μm max (circular) - 220 μm recommended</td>
</tr>
<tr>
<td>Solder mask opening</td>
<td>Ø = 300 μm min (for 260 μm diameter pad)</td>
</tr>
</tbody>
</table>

**Table 6. PCB design recommendation for 0.4 mm ball pitch packages**

**Micro vias**

An alternative to routing on the top surface is to route out on buried layers. To achieve this, the pads must be connected to the lower layers using micro vias.

4.2 PCB assembly guidelines

To mount a WLCSP on a PCB, ST recommends the use of a solder stencil with an aperture of 330 x 330 μm² maximum and a stencil typical thickness of 125 μm. WLCSP are fully compatible with the use of near-eutectic SAC solder paste with no-clean flux.

ST's recommendations for WLCSP board mounting are illustrated on the soldering reflow profile shown in Figure 11:

- **Dwell time in the soldering zone (with temperature higher than 220 °C) has to be kept as short as possible to prevent component and substrate damages.**
- **Peak temperature must not exceed 260 °C.**
- **Controlled atmosphere (N₂ or N₂H₂) is recommended during the whole reflow, especially when the temperature is above 150 °C.**

WLCSP can withstand three times the previous recommended reflow profile to be compatible with a double reflow when SMDs are mounted on both sides of the PCB plus one additional repair.
A maximum of three soldering reflows are allowed for these Lead-free packages (with repair step included).

The use of a no-clean flux is highly recommended to avoid any cleaning operation. To prevent any bump cracks, ultrasonic cleaning methods are not recommended.

### 4.2.1 Protection against light exposure

WLCSP, when placed in a non-opaque housing for specific customer application, may be exposed to various light sources such as incandescent light or sun light. The WLCSP light sensitivity may interfere with the device operation by generating unwelcome electrical currents/voltages, performance degradation, malfunction or shutdown. It is therefore mandatory to protect WLCSP with an opaque layer to prevent light from entering the semiconductor substrate through the top side (marking side) and the lateral edges of device.

### 4.2.2 Underfilling

Underfilling is not required for WLCSPs. However, the devices can dispense with an underfill if the process temperature does not exceed 175 °C and the process time is short (typically 5 min.).
5 Manual rework

WLCSP can tolerate one repair in addition to the two reflows mentioned above.

Like other BGA packages, the use of laser systems is the most suitable solution to repair WLCSP. Manual hot gas soldering is acceptable while iron soldering is not recommended.

The maximum temperature allowed for Lead-free WLCSP manual rework is 260 °C. The typical soldering profile shown Figure 11 can be used.

5.1 Rework procedure

To perform manual rework on a WLCSP, follow the steps below:

1. Remove the device

To remove the device, heat must be applied to melt the solder joints so that the component can be lifted from the board.

Large area bottom side preheaters may be used to raise the temperature of the board. This may help to minimize board warpage and the amount of heat that must be applied on the component.

Top heating may be applied to the component by using a laser or a convective hot gas nozzle. Nozzle size must be selected to match the component footprint. After top heating has melted the solder, vacuum is applied through the pick-up nozzle, and the component is lifted from the board.

The heat should be carefully directed at the component which must be removed to prevent adjacent components solder joints from being reflowed. Shielding, control of the gas flow from the nozzle, and accurate temperature control are the key parameters.

2. Remove the solder

Automatic tools are recommended due to space constraints and the need for accurate temperature control,

Typical cleaners are controlled non-contact gas heating and vacuuming tools. The objective is to remove the residual solder from the area without damaging the pads, solder masks or adjacent components, and to prepare the area for the insertion of the new component.

3. New device soldering

a) Place the new device

There are several solutions to place the new device:

– Use a mini-stencil and solder paste, then place the device. This is the solution recommended to ensure homogeneity of assembly conditions if solder paste is used, even if small footprints and tight dimensions make this operation difficult.

– Use no-clean flux on the area and place the device over the flux on the board.

– Dip the WLCSP in no-clean flux, and place it on the board.

b) Reflow the solder joint by applying controlled heat to the component.

The steps are similar to those required to remove a component. However, accurate temperature control is recommended to ensure good joint soldering. A alternative solution is to put the whole board in a furnace. See Figure 11 for reflow profile recommendations.
5.2 Component rework equipment

The systems required to perform rework are available at various levels of automation. The methods and techniques used in more sophisticated automatic systems can be copied for manual equipment. Soldering irons must be avoided for these operations. Tweezers or picking tools must be avoided since they can damage devices and create die chip-outs by compressing the WLCSP top or bottom sides (ball side).

Figure 8. shows an example of semi-automatic equipment for component rework. For more information, refer to Comintec web site at http://www.comintec.it.

Figure 12. Comintec ONYX32 semi-automatic equipment for component rework
6 Package changes

STMicroelectronics reserves the right to implement minor changes of geometry and manufacturing processes without prior notice. Such changes will not affect electrical characteristics of the die, the pad layout or the maximum die size. However for confirmed orders, no variation will be made without prior customer’s approval.

7 Package quality and reliability

7.1 Electrical inspection

All the critical parameters defined in the WLCSP device datasheet are 100% electrically characterized. The other parameters are guaranteed by technology, design rules or by continuous monitoring systems.

7.2 Visual inspection

A visual control is performed on all manufacturing lots according to JESD22_B101B specification.

7.3 WLCSP reliability

As mentioned in Section 2.1: Overview, WLCSP packages must be handled with care as active Silicon substrate is not protected against aggressive mechanical actions. 

if this is not the case, the WLCSP layers and/or Silicon device layers may be physically damaged. This may increase the sensitivity to humidity and lead to long-term reliability electrical failures.

Assuming careful handling is ensured, WLCSP packages for microcontrollers are qualified to sustain 500 hrs of Temperature Humidity Biased in JESD22-A101 conditions: 85°C/85%RH.

Information on mission profiles extended above 500 hrs in JESD22-A101 conditions are available on demand.

In any case, WLCSP packages are not recommended for use in harsh environments. Molded packages should be selected for use in aggressive Temperature & Humidity mission profiles.
8 Conclusion

Lead-free WLCSP have been developed by STMicroelectronics for electronic applications where integration and performance are designer’s main concerns.

STMicroelectronics WLCSP key features are:

- Remarkable board space saving: package size equal to die size and total height less than 650 μm
- Enhanced electrical performance: minimized parasitic inductance due to very short electrical paths.

WLCSP are delivered in tape and reel and are fully compatible with other high volume SMD components (standard plastic packages or CSP/BGA packages) in regards to existing pick-and-place equipment, standard solder reflow assembly equipment and standard PCB techniques.
9 Revision history

Table 7. Document revision history

<table>
<thead>
<tr>
<th>Date</th>
<th>Revision</th>
<th>Changes</th>
</tr>
</thead>
<tbody>
<tr>
<td>16-Dec-2013</td>
<td>1</td>
<td>Initial release. Document converted from Package information PI0297 revision 5.</td>
</tr>
<tr>
<td>25-Jun-2014</td>
<td>2</td>
<td>Added WLCSP36, WLCSP66, WLCSP72, WLCSP104 and WLCSP168. Updated Figure 4: Typical tape dimensions for WLCSPs to indicate A1 bump position and removed note 1 related to A1 bump location. Updated Section 7 title and added Section 7.3: WLCSP reliability.</td>
</tr>
<tr>
<td>01-Feb-2016</td>
<td>3</td>
<td>Updated – Table 1: WLCSPs for microcontrollers – Section 3.4: Final packing</td>
</tr>
<tr>
<td>26-Jul-2016</td>
<td>4</td>
<td>Updated – Section 3.6: Storage and shipping recommendations</td>
</tr>
</tbody>
</table>
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